A Complete Bibliography of Publications in *Technometrics* for the decade 1960–1969

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01 October 2024
Version 1.03

Title word cross-reference

2 [DT68]. 2^{17-9} [Add65, Pre66]. 2^{k-p} [BH61a, BH61b]. 2^n
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[DW66a]. $2\hat{I}$ [Ku63b]. 2×2 [Owe65c, Owe66a]. 2×3 [BN63, BN64]. $3(2^{n-k})$
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[Ano62g]   Anonymous. Front matter. *Technometrics*, 4(1):??, February 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266168`.

Anonymous:1962:FMb

[Ano62h]   Anonymous. Front matter. *Technometrics*, 4(2):293–298, May 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266615`.

Anonymous:1962:FMc

[Ano62i]   Anonymous. Front matter. *Technometrics*, 4(3):??, August 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266569`.

Anonymous:1962:FMd

[Ano62j]   Anonymous. Front matter. *Technometrics*, 4(4):621, November 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266282`.

Anonymous:1962:PR

[Ano62k]   Anonymous. Publications received. *Technometrics*, 4(4):623–624, November 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266302`.

Anonymous:1962:VI

[Ano62l]   Anonymous. Volume information. *Technometrics*, 4(4):625–627, November 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266281`.

Anonymous:1963:BMa

[Ano63a]   Anonymous. Back matter. *Technometrics*, 5(1):135–140, February 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266503.

Anonymous:1963:BMb

[Ano63b]   Anonymous. Back matter. *Technometrics*, 5(2):294–296, May 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266086.

Anonymous:1963:BMc

[Ano63c]   Anonymous. Back matter. *Technometrics*, 5(3):418–420, August 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266355.

Anonymous:1963:BMd

[Ano63d]   Anonymous. Back matter. *Technometrics*, 5(4):539–546, November 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266039.

Anonymous:1963:BRa

[Ano63e]   Anonymous. Books received. *Technometrics*, 5(1):133, February 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266501.

Anonymous:1963:BRb

[Ano63f]   Anonymous. Books received. *Technometrics*, 5(2):291, May 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266084.

Anonymous:1963:BRc

[Ano63g]   Anonymous. Books received. *Technometrics*, 5(4):533–534, November 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266037.

Anonymous:1963:EFN

[Ano63h]   Anonymous. Errata: "Finding New Fractions of Factorial Experimental Designs". *Technometrics*, 5(1):134, February 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266502. See [Fry61].

Anonymous:1963:EFB

[Ano63i]   Anonymous. Errata to Finney, Box and Guterman. *Technometrics*, 5(3):417, August 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266354`. See [Fin63, Box63, Gut62].

Anonymous:1963:FMa

[Ano63j]   Anonymous. Front matter. *Technometrics*, 5(1):??, February 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266487`.

Anonymous:1963:FMb

[Ano63k]   Anonymous. Front matter. *Technometrics*, 5(2):??, May 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266058`.

Anonymous:1963:FMc

[Ano63l]   Anonymous. Front matter. *Technometrics*, 5(3):??, August 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266333`.

Anonymous:1963:FMd

[Ano63m]   Anonymous. Front matter. *Technometrics*, 5(4):??, November 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266018`.

Anonymous:1963:VI

[Ano63n]   Anonymous. Volume information. *Technometrics*, 5(4):543–545, November 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266017`.

Anonymous:1964:APP

[Ano64a]   Anonymous. Abstracts of papers presented at SPES Session of the 123rd Annual Meeting of the American Statistical Association. *Technometrics*, 6(1):115–125, February 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266756`.

Anonymous:1964:BMa

[Ano64b]   Anonymous. Back matter. *Technometrics*, 6(1):129–132, February 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266759`.

Anonymous:1964:BMb

[Ano64c]   Anonymous. Back matter. *Technometrics*, 6(2):??, May 1964. CO-DEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266167.

Anonymous:1964:BMc

[Ano64d]   Anonymous. Back matter. *Technometrics*, 6(3):341–342, August 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266057.

Anonymous:1964:BRa

[Ano64e]   Anonymous. Books received. *Technometrics*, 6(3):339–340, August 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266056.

Anonymous:1964:BRb

[Ano64f]   Anonymous. Books received. *Technometrics*, 6(4):476, November 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266106.

Anonymous:1964:EDB

[Ano64g]   Anonymous. Errata: "The Discrimination between Two Weibull Processes". *Technometrics*, 6(2):??, May 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266166. See [Qur64].

Anonymous:1964:EHH

[Ano64h]   Anonymous. Errata to Halperin and Harter. *Technometrics*, 6(4):482–483, November 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266108. See [Hal64, Har64].

Anonymous:1964:FMa

[Ano64i]   Anonymous. Front matter. *Technometrics*, 6(1):??, February 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266742.

Anonymous:1964:FMb

[Ano64j]   Anonymous. Front matter. *Technometrics*, 6(2):239–240, May 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266147.

Anonymous:1964:FMc

[Ano64k]   Anonymous. Front matter. *Technometrics*, 6(3):??, August 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266040.

Anonymous:1964:FMd

[Ano64l]   Anonymous. Front matter. *Technometrics*, 6(4):479–481, November 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266088.

Anonymous:1964:VI

[Ano64m]   Anonymous. Volume information. *Technometrics*, 6(4):484–486, November 1964. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266087.

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[Ano65a]   Anonymous. Abstracts of papers presented at SPES Session of the 124th Annual Meeting of the American Statistical Association. *Technometrics*, 7(2):267–277, May 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266682.

Anonymous:1965:BMa

[Ano65b]   Anonymous. Back matter. *Technometrics*, 7(1):94, February 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266146.

Anonymous:1965:BMb

[Ano65c]   Anonymous. Back matter. *Technometrics*, 7(2):282, May 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266684.

Anonymous:1965:BMc

[Ano65d]   Anonymous. Back matter. *Technometrics*, 7(4):665–672, November 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266415.

Anonymous:1965:BRa

[Ano65e]   Anonymous. Books received. *Technometrics*, 7(1):89–90, February 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266144.

Anonymous:1965:BRb

[Ano65f]   Anonymous. Books received. *Technometrics*, 7(2):266, May 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266681.

Anonymous:1965:BRc

[Ano65g]   Anonymous. Books received. *Technometrics*, 7(3):457–458, August 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266612.

Anonymous:1965:BRd

[Ano65h]   Anonymous. Books received. *Technometrics*, 7(4):663–664, November 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266414.

Anonymous:1965:END

[Ano65i]   Anonymous. Errata: "A Note on the Determination of Connectedness in an N-Way Cross Classification". *Technometrics*, 7(2):281, May 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266683. See [WW64].

Anonymous:1965:EEC

[Ano65j]   Anonymous. Errata: "Estimation of a Component of a Convolution, When the Other Component Is of Exponential Type". *Technometrics*, 7(3):462, August 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266614. See [Sch64].

Anonymous:1965:ESF

[Ano65k]   Anonymous. Errata: "Sequential Factorial Estimation". *Technometrics*, 7(1):93, February 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266145. See [Hun64].

Anonymous:1965:FMa

[Ano65l]   Anonymous. Front matter. *Technometrics*, 7(1):91–92, February 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266122.

Anonymous:1965:FMb

[Ano65m]   Anonymous. Front matter. *Technometrics*, 7(2):279–280, May 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266665.

Anonymous:1965:FMc

[Ano65n]   Anonymous. Front matter. *Technometrics*, 7(3):459–460, August 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266588.

Anonymous:1965:FMd

[Ano65o]   Anonymous. Front matter. *Technometrics*, 7(4):??, November 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266387.

Anonymous:1965:VI

[Ano65p]   Anonymous. Volume information. *Technometrics*, 7(4):667–670, November 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266386.

Anonymous:1966:ASS

[Ano66a]   Anonymous. Abstracts of SPES Sessions of 125th Annual Meeting of ASA. *Technometrics*, 8(1):203–211, February 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266278.

Anonymous:1966:BMa

[Ano66b]   Anonymous. Back matter. *Technometrics*, 8(1):216, February 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266280.

Anonymous:1966:BMb

[Ano66c]   Anonymous. Back matter. *Technometrics*, 8(2):388, May 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266385.

Anonymous:1966:BMc

[Ano66d]   Anonymous. Back matter. *Technometrics*, 8(3):??, August 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266712.

Anonymous:1966:BMd

[Ano66e]   Anonymous. Back matter. *Technometrics*, 8(4):737–738, November 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266664.

Anonymous:1966:E

[Ano66f]   Anonymous. Editorial. *Technometrics*, 8(1):1–2, February 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266257.

Anonymous:1966:EMD

[Ano66g]   Anonymous. Errata: "Misclassified Data from a Binomial Population". *Technometrics*, 8(1):215, February 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266279. See [Coh60].

Anonymous:1966:EOU

[Ano66h]   Anonymous. Errata: "The Orthogonalization of Undesigned Experiments". *Technometrics*, 8(4):731, November 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266663. See [Dyk66b].

Anonymous:1966:EIV

[Ano66i]   Anonymous. Errata to index of volumes 1–7. *Technometrics*, 8(2):387, May 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266384.

Anonymous:1966:EOC

[Ano66j]   Anonymous. Errata to Owen and Cohen. *Technometrics*, 8(3):570, August 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266711. See [Owe65c, Coh66b].

Anonymous:1966:FMa

[Ano66k]   Anonymous. Front matter. *Technometrics*, 8(1):213, February 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266256.

Anonymous:1966:FMb

[Ano66l]   Anonymous. Front matter. *Technometrics*, 8(2):385–386, May 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266356.

Anonymous:1966:FMc

[Ano66m]   Anonymous. Front matter. *Technometrics*, 8(3):569, August 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266685.

Anonymous:1966:FMd

[Ano66n]   Anonymous. Front matter. *Technometrics*, 8(4):??, November 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266631.

Anonymous:1966:VI

[Ano66o]   Anonymous. Volume information. *Technometrics*, 8(4):733–736, November 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266630.

Anonymous:1967:ASS

[Ano67a]   Anonymous. Abstracts of SPES Sessions of 126th Annual Meeting of ASA. *Technometrics*, 9(1):185–194, February 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266330.

Anonymous:1967:BMa

[Ano67b]   Anonymous. Back matter. *Technometrics*, 9(1):196, February 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266332.

Anonymous:1967:BMb

[Ano67c]   Anonymous. Back matter. *Technometrics*, 9(2):354, May 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266440.

Anonymous:1967:BMc

[Ano67d]   Anonymous. Back matter. *Technometrics*, 9(3):??, August 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266524.

Anonymous:1967:BMd

[Ano67e]   Anonymous. Back matter. *Technometrics*, 9(4):707–710, November 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266217.

Anonymous:1967:EQC

[Ano67f]   Anonymous. Errata: "Query 21: Comparison of Sample Sizes in Inverse Binomial Sampling". *Technometrics*, 9(4):695, November 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266208`. See [Bar67a].

Anonymous:1967:EBM

[Ano67g]   Anonymous. Errata to Bartko and Mohan. *Technometrics*, 9(3): 498, August 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266523`. See [BGCR67, Moh67].

Anonymous:1967:EHW

[Ano67h]   Anonymous. Errata to Harter and Weiler. *Technometrics*, 9(1):195, February 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266331`. See [Har67b, Wei66].

Anonymous:1967:FMa

[Ano67i]   Anonymous. Front matter. *Technometrics*, 9(1):??, February 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266313`.

Anonymous:1967:FMb

[Ano67j]   Anonymous. Front matter. *Technometrics*, 9(2):351–352, May 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266416`.

Anonymous:1967:FMc

[Ano67k]   Anonymous. Front matter. *Technometrics*, 9(3):??, August 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266504`.

Anonymous:1967:FMd

[Ano67l]   Anonymous. Front matter. *Technometrics*, 9(4):??, November 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266189`.

Anonymous:1967:VI

[Ano67m]   Anonymous. Volume information. *Technometrics*, 9(4):711–714, November 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266188.

Anonymous:1968:APP

[Ano68a]   Anonymous. Abstracts of papers presented at SPES Session of the 127th Annual Meeting of the American Statistical Association. *Technometrics*, 10(2):419–427, May 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267068.

Anonymous:1968:BMa

[Ano68b]   Anonymous. Back matter. *Technometrics*, 10(1):217–218, February 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266245.

Anonymous:1968:BMb

[Ano68c]   Anonymous. Back matter. *Technometrics*, 10(2):435–438, May 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267070.

Anonymous:1968:BMc

[Ano68d]   Anonymous. Back matter. *Technometrics*, 10(3):636, August 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267128.

Anonymous:1968:BMd

[Ano68e]   Anonymous. Back matter. *Technometrics*, 10(4):885–892, November 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267483.

Anonymous:1968:EML

[Ano68f]   Anonymous. Erratum: "Maximum-Likelihood Estimation of the Parameters of a Four-Parameter Generalized Gamma Population from Complete and Censored Samples". *Technometrics*, 10(3):635, August 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267127. See [Har67b].

Anonymous:1968:FMa

[Ano68g]   Anonymous. Front matter. *Technometrics*, 10(1):??, February 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266218.

Anonymous:1968:FMb

[Ano68h]   Anonymous. Front matter. *Technometrics*, 10(2):??, May 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267039.

Anonymous:1968:FMc

[Ano68i]   Anonymous. Front matter. *Technometrics*, 10(3):??, August 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267099.

Anonymous:1968:FMd

[Ano68j]   Anonymous. Front matter. *Technometrics*, 10(4):??, November 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267449.

Anonymous:1968:VI

[Ano68k]   Anonymous. Volume information. *Technometrics*, 10(4):887–891, November 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267448.

Anonymous:1969:APP

[Ano69a]   Anonymous. Abstracts of papers presented at SPES session of the 128th annual meeting of the American statistical association. *Technometrics*, 11(1):211–221, February 1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266782.

Anonymous:1969:BMa

[Ano69b]   Anonymous. Back matter. *Technometrics*, 11(1):223–239, February 1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266783.

Anonymous:1969:BMb

[Ano69c]   Anonymous. Back matter. *Technometrics*, 11(2):??, May 1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267279.

Anonymous:1969:BMc

[Ano69d]   Anonymous. Back matter. *Technometrics*, 11(3):628, August
            1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (elec-
            tronic). URL `http://www.jstor.org/stable/1267038`.

Anonymous:1969:BMd

[Ano69e]   Anonymous. Back matter. *Technometrics*, 11(4):845–847, Novem-
            ber 1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723
            (electronic). URL `http://www.jstor.org/stable/1266911`.

Anonymous:1969:EDD

[Ano69f]   Anonymous. Errata to Draper and DeGray. *Technometrics*, 11(3):
            627, August 1969. CODEN TCMTA2. ISSN 0040-1706 (print),
            1537-2723 (electronic). URL `http://www.jstor.org/stable/`
            `1267037`. See [DHT69, DeG68b].

Anonymous:1969:FMa

[Ano69g]   Anonymous. Front matter. *Technometrics*, 11(1):207–210, Febru-
            ary 1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723
            (electronic). URL `http://www.jstor.org/stable/1266760`.

Anonymous:1969:FMb

[Ano69h]   Anonymous. Front matter. *Technometrics*, 11(2):401–402, May
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            tronic). URL `http://www.jstor.org/stable/1267016`.

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            2723 (electronic). URL `http://www.jstor.org/stable/1266883`.

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[AR69]   L. A. Aroian and D. E. Robison. Direct methods for exact truncated sequential tests of the mean of a normal distribution. *Technometrics*, 11(4):661–675, November 1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL `http://www.jstor.org/stable/1266890`.

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[Bar62c] John J. Bartko. A note on the negative binomial distribution. *Technometrics*, 4(4):609–610, November 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266292.

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[Bar63a] Richard E. Barlow. Book review: *Renewal Theory* by D. R. Cox. *Technometrics*, 5(4):529–530, November 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266033.

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[Bar63c] M. S. Bartlett. Book review: *Proceedings of the Fourth Berkeley Symposium on Mathematical Statistics and Probability. Vol. III: Contributions to Astronomy, Meteorology and Physics* by J. Neyman. *Technometrics*, 5(2):279–280, May 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266075.

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[Bar67a] D. E. Barton. Query 21: Comparison of sample sizes in inverse binomial sampling. *Technometrics*, 9(2):337–339, May 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266432. See errata [Ano67f].

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[BC62]   Kathleen H. V. Booth and D. R. Cox. Some systematic supersaturated designs. *Technometrics*, 4(4):489–495, November 1962. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266285.

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[BC63]   G. A. Barnard and D. R. Cox. Letter to the Editor. *Technometrics*, 5(3):416, August 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266353.

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[BC66]   John J. Beauchamp and Richard G. Cornell. Simultaneous nonlinear estimation. *Technometrics*, 8(2):319–326, May 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266364. See errata [BC67].

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[BC67]   John J. Beauchamp and Richard G. Cornell. Errata to: "Simultaneous nonlinear estimation". *Technometrics*, 9(2):353, May 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266439. See [BC66].

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[BC69]   John J. Beauchamp and Richard G. Cornell. Spearman simultaneous estimation for a compartmental model. *Technometrics*, 11(3):551–560, August 1969. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267024.

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[Bec68a]   Robert E. Bechhofer. Multiple comparisons with a control for multiply-classified variances of normal populations. *Technometrics*, 10(4):715–718, November 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267454.

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[Bec68b]   Robert E. Bechhofer. Single-stage procedures for ranking multiply-classified variances of normal populations. *Technometrics*, 10(4):693–714, November 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1267453.

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[Ber61]   William Beranek. Book review: *Dynamic Programming and Markov Processes* by Ronald A. Howard. *Technometrics*, 3(1):120–121, February 1961. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266484.

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[Ber66]   Harald Bergström. Book review: *Mathematical Theory of Probability and Statistics* by Richard von Mises; Hilda Geiringer. *Technometrics*, 8(3):547–548, August 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266701.

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[BF65] L. N. Balaam and W. T. Federer. Query 11: Error rate bases. *Technometrics*, 7(2):260–262, May 1965. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266676.

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[BGCR67] John J. Bartko, B. K. Ghosh, C. Philip Cox, and Thomas D. Roseberry. Letters to the Editor. *Technometrics*, 9(2):347–350,

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[BH61a]   G. E. P. Box and J. S. Hunter. The 2^{k-p} fractional factorial designs. Part I. *Technometrics*, 3(3):311–351, August 1961. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266725.

Box:1961:FFDb

[BH61b]   G. E. P. Box and J. S. Hunter. The 2^{k-p} fractional factorial designs Part II. *Technometrics*, 3(4):449–458, November 1961. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266553. See errata [Ano61g].

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[BK68] V. P. Bhapker and Gary G. Koch. Hypotheses of 'no interaction' in multi-dimensional contingency tables. *Technometrics*, 10 (1):107–123, February 1968. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor. org/stable/1266228.

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[BLH+60] G. A. Barnard, D. V. Lindley, B. Hill, I. J. Good, G. Horsnell, D. R. Cox, F. J. Anscombe, and A. Hald. Discussion of the papers of Messrs. Hald, Wetherill and Cox. *Technometrics*, 2(3):361–372, August 1960. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266250. See [Hal60, Wet60, Cox60].

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[Blo66] Gunnar Blom. Book review: *Convex Transformations of Random Variables* by W. R. van Zwet. *Technometrics*, 8(2):380–381, May 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266380.

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[Blu66] Saul Blumenthal. Book review: *Probability and Its Engineering Uses* by Thornton C. Fry. *Technometrics*, 8(2):372–375, May 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266376.

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[Blu67] Saul Blumenthal. Proportional sampling in life length studies. *Technometrics*, 9(2):205–218, May 1967. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www. jstor.org/stable/1266418.

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[BMW66] Ralph A. Bradley, Sarla D. Merchant, and Frank Wilcoxon. Sequential rank tests. II. Modified two-sample procedures. *Technometrics*, 8(4):615–623, November 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266634.

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[BN63] B. M. Bennett and E. Nakamura. Tables for testing significance in a 2×3 contingency table. *Technometrics*, 5(4):501–511, November 1963. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266026.

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[Bor66] J. R. Borsting. Book review: *Probability and Statistics for Engineers* by I. Miller; J. E. Freund. *Technometrics*, 8(2):383–384, May 1966. CODEN TCMTA2. ISSN 0040-1706 (print), 1537-2723 (electronic). URL http://www.jstor.org/stable/1266383.

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